

MNDS90LV032A-X REV 0A0

 Original Creation Date: 2/21/00
 Last Update Date: 03/17/00
 Last Major Revision Date: 2/21/00

Low Voltage LVDS Quad CMOS Differential Line Receiver

General Description

The DS90LV032A is a quad differential line receiver designed for applications requiring low power dissipation and high data rates.

The DS90LV032A accepts low voltage differential input signals and translates them to 3V CMOS output levels. The receiver supports a TRI-STATE function that may be used to multiplex outputs.

The DS90LV032A and companion LVDS line driver (DS90LV031A) provide a new alternative to high power pseudo-ECL devices for high speed point to point interface applications.

Industry Part Number

DS90LV032A

NS Part Numbers

 DS90LV032AW-QML*
 DS90LV032AWGMLS
 DS90LV032AWGQML**

Prime Die

DS90LV032A

Controlling Document

5962-9865201QFA*, QXA**

Processing

MIL-STD-883, Method 5004

Quality Conformance Inspection

MIL-STD-883, Method 5005

Subgrp	Description	Temp (°C)
1	Static tests at	+25
2	Static tests at	+85
3	Static tests at	-55
4	Dynamic tests at	+25
5	Dynamic tests at	+85
6	Dynamic tests at	-55
7	Functional tests at	+25
8A	Functional tests at	+85
8B	Functional tests at	-55
9	Switching tests at	+25
10	Switching tests at	+85
11	Switching tests at	-55

Features

- Accepts small swing (330 mV) differential signal levels.
- Low power dissipation.
- Low differential skew.
- Low chip to chip skew
- +85C thru -55C operating temperature range
- Pin compatible with DS90C032A and DS26C32A.
- Compatible with ANSI/TIA/EIA-644
- Typical Rise/Fall time is TBD

(Absolute Maximum Ratings)

(Note 1)

Supply Voltage (Vcc)	-0.3 to +4V
Input Voltage (RIN+, RIN-)	-0.3 to 3.9V
Enable Input Voltage (EN, EN*)	-0.3 to (Vcc+0.3V)
Output Voltage (ROUT)	-0.3 to (Vcc+0.3V)
Storage Temperature Range (Tstg)	-65C to + 150C
Lead Temperature Soldering 4 seconds	260 C
Maximum Package Power Dissipation @ +25C (Note 2)	
16 PIN CERPAK (W Pkg)	845mW
16 PIN CERAMIC SOIC (WG Pkg)	845mW
Thermal Resistance. (Theta JA)	
16 PIN CERPAK (W Pkg)	148 C/W
16 PIN CERAMIC SOIC (WG Pkg)	148 C/W
Thermal Resistance. (Theta JC)	
16 PIN CERPAK (W Pkg)	21 C/W
16 PIN CERAMIC SOIC (WG Pkg)	21 C/W
ESD Rating.	4500 Volts.
Maximum Junction Temperature	+150C

Note 1: Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Derate (W & WG Pkgs) @ 6.8 mW/C above +25C.

Recommended Operating Conditions

Operating Voltage (Vcc)	3.15V to 3.45V
Operating Temperature Range (Ta)	-55C to +85C
Receiver Input Voltage	GND to 3.0V

Electrical Characteristics

DC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)

DC: Over supply voltage range of 3.15V to 3.45V and operating temperature of -55C to +85C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
VTL	Differential Input Low Threshold	Vcm = +1.2V	1	RIN+, RIN-	-100		mV	1, 2, 3
VTH	Differential Input High Threshold	Vcm = +1.2V	1	RIN+, RIN-		100	mV	1, 2, 3
VCMR	Common Mode Voltage Range	VID = 200mV peak to peak	1, 4	RIN+, RIN-	0.1	2.3	V	1, 2, 3
IIN	Input Current	Vcc = 3.45V or 0V, Vin = 2.8V or 0V		RIN+, RIN-		±10	uA	1, 2, 3
		Vcc = 0V, Vin = 3.45V		RIN+, RIN-		±20	uA	1, 2, 3
VOH	Output High Voltage	Ioh = -0.4 mA, Vid = 200mV		ROUT	2.7		V	1, 2, 3
		Ioh = -0.4 mA, Inputs Open		ROUT	2.7		V	1, 2, 3
VOL	Output Low Voltage	Iol = 2 mA, Vid = -200mV		ROUT		0.25	V	1, 2, 3
IOS	Output Short Circuit Current	Enabled, Vout = 0V	5	ROUT	-15	-120	mA	1, 2, 3
IOZ	Output TRI-STATE Current	Disabled, Vout = 0V or Vcc		ROUT		±10	uA	1, 2, 3
VIH	Input High Voltage		6	EN, EN*	2.0	Vcc	V	1, 2, 3
VIL	Input Low Voltage		6	EN, EN*	GND	0.8	V	1, 2, 3
II	Input Current	Vin = Vcc or 0V, Other Input = Vcc or GND		EN, EN*		±10	uA	1, 2, 3
VCL	Input Clamp Voltage	Icl = -18mA		EN, EN*		-1.5	V	1, 2, 3
Icc	No Load Supply Current Receivers Enabled	EN, EN* = Vcc or GND, Inputs Open		Vcc		15	mA	1, 2, 3
		EN, EN* = 2.4 or 0.5, Inputs Open		Vcc		15	mA	1, 2, 3
IccZ	No Load Supply Current Receivers Disabled	EN = GND, EN* = Vcc, Inputs Open		Vcc		5	mA	1, 2, 3

Electrical Characteristics

AC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)

AC: VCC = 3.15/3.30/3.45V, CL = 20pF

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
tPHLD	Differential Propagation Delay High to Low	Vid = 200mV, Input pulse = 1.1V to 1.3V, Vin = 1.2V (0 differential) to Vout = 1/2 Vcc			0.5	3.5	ns	9, 10, 11
tPLHD	Differential Propagation Delay Low to High	Vid = 200mV, Input pulse = 1.1V to 1.3V, Vin = 1.2V (0V differential) to Vout = 1/2 Vcc			0.5	3.5	ns	9, 10, 11
tSKD	Differential Skew tPHLD-tPLHD	CL = 20pF, Vid = 200mV				1.5	ns	9, 10, 11
tSK1	Channel to Channel Skew	CL = 20pF, Vid = 200mV	2			1.75	ns	9, 10, 11
tSK2	Chip to Chip Skew	CL = 20pF, Vid = 200mV	3			3.0	ns	9, 10, 11
tPLZ	Disable Time Low to Z	Input pulse = 0V to 3.0V, Vin = 1.5V, Vout = Vol+0.5V, RL = 1K Ohm.				12	ns	9, 10, 11
tPHZ	Disable Time High to Z	Input pulse = 0V to 3.0V, Vin = 1.5V, Vout = Voh-0.5V, RL = 1K Ohm.				12	ns	9, 10, 11
tPZH	Enable Time Z to High	Input pulse = 0V to 3.0V, Vin = 1.5V, Vout = 50%, RL = 1K Ohm.				20	ns	9, 10, 11
tPZL	Enable Time Z to Low	Input pulse = 0V to 3.0V, Vin = 1.5V, Vout = 50%, RL = 1K Ohm.				20	ns	9, 10, 11

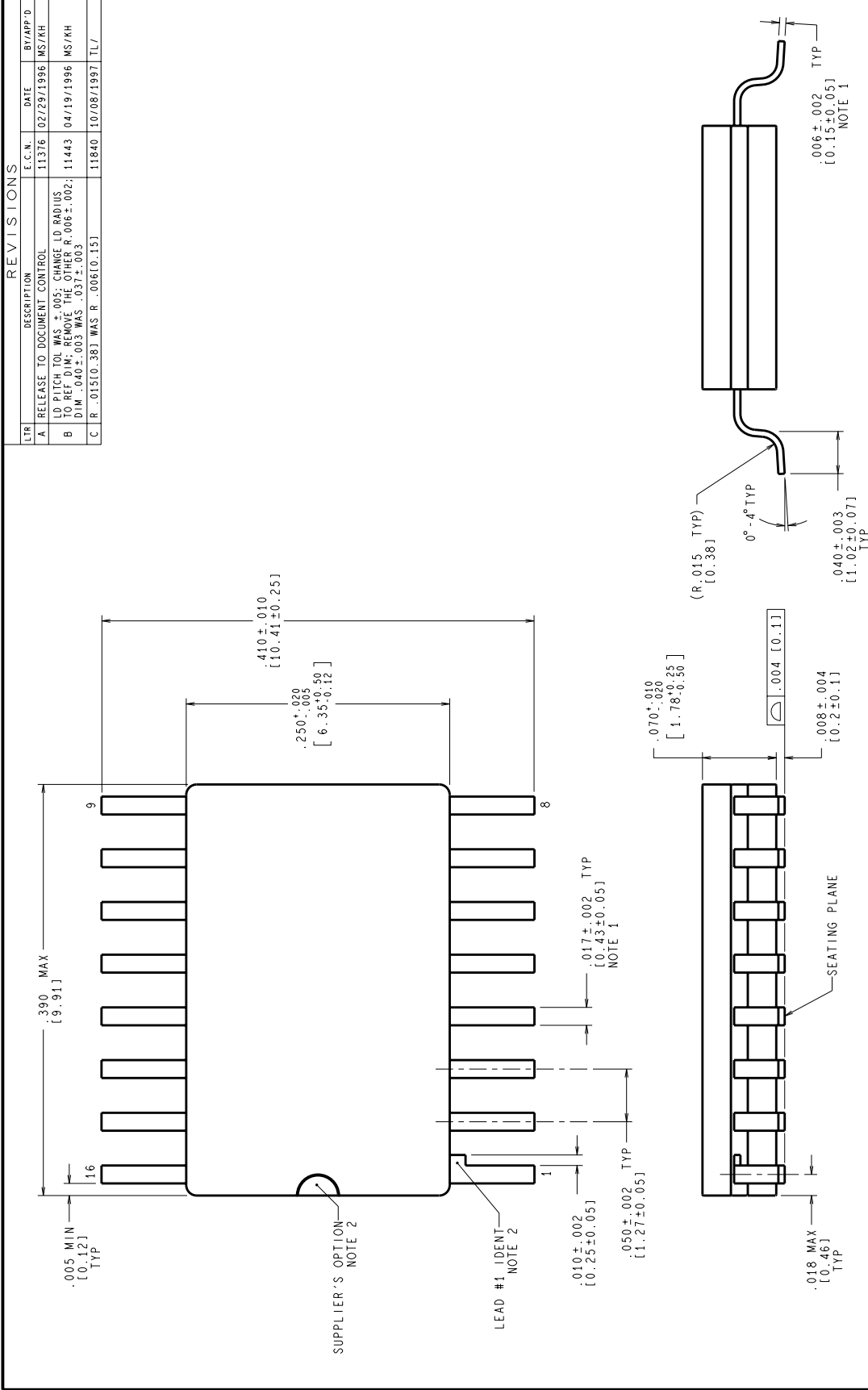
- Note 1: Tested during VOH/VOL tests by applying appropriate voltage levels to the input pins of the device under test.
- Note 2: Channel to Channel Skew is defined as the difference between the propagation delay of one channel and that of the others on the same chip with any event on the inputs.
- Note 3: Chip to Chip Skew is defined as the difference between the minimum and maximum specified differential propagation delays.
- Note 4: The VCMR range is reduced for larger input differential voltage (VID). Example: If VID = 400mV, the VCMR is 0.2V to 2.2V. A VID up to Vcc- 0V may be applied to the Rin+/Rin- inputs with the Common-Mode voltage set to Vcc/2.
- Note 5: Output short circuit current (Ios) is specified as magnitude only, minus sign indicates direction of current. Only one output should be shorted at a time, do not exceed maximum junction temperature.
- Note 6: Tested during IOZ tests by applying appropriate threshold voltage levels to the EN and EN* pins.

Graphics and Diagrams

GRAPHICS#	DESCRIPTION
W16ARL	CERPACK (W), 16 LEAD (P/P DWG)
WG16ARC	CERAMIC SOIC (WG), 16 LEAD (P/P DWG)

See attached graphics following this page.

REVISIONS			
LTR	DESCRIPTION	E.C.N.	DATE
A	RELEASE TO DOCUMENT CONTROL	11376	02/29/1996
B	LD PITCH TOL WAS $\pm .005$; CHANGE LD RADIUS TO REF DIM; REMOVE THE OTHER R .006 $\pm .002$; DIM .040 $\pm .003$ WAS $.037 \pm .003$	11443	04/19/1996
C	R .015(0.38) WAS R .006(0.15)	11840	10/08/1997



MIL-PRF-38535 CONFIGURATION CONTROL

CONTROLLING DIMENSION IS INCH
VALUES IN | ARE MILLIMETERS

APPROVALS	DATE	SCALE	SIZE	DRAWING NUMBER	REV
DESIGN MARTY SUCHY	02/29/96	N/A	C	(SC)MKT-WG16A	C
ENGINEER CHK.					
TESTER CHK.					
<p>PROJECTION</p> <p>1" = 1"</p>					
<p>DO NOT SCALE DRAWING</p>					

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**CERPACK,
16 LEAD,
GULL WING**